



Form PTO-1449 US Dept. of Commerce PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY DOCKET NO. D/A1087	APPLICATION NO. 09/901,508
	APPLICANT Christopher R. Dance	
	FILING DATE 7/9/2001	GROUP ART UNIT 2621

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION DATE	NAME OF PATENTEE	CLASS	SUB CLASS
Jc	5,355,420	10/11/94	Bloomberg et al.	382	046

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FOREIGN PATENT DOCUMENTS

	COUNTRY	DOCUMENT NUMBER	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	TRANSLATION Y/N

OTHER DOCUMENTS (Including Author (in CAPS), Title, Publication Date, Pages, etc.)

Jc	New Release on Pixid Inc.'s Whiteboard Photo product, April 2000, available on the Internet at http://www.thejournal.com/magazine/vault/A2816.cfm .
Jc	S. T. BARNARD, "Interpreting perspective images", Artificial Intelligence, 21:435-462, 1983.
Jc	BLOOMBERG, D.S., KOPEC, G.E., AND DASARI, L., "Measuring document image skew and orientation", in SPIE Conference on Document Recognition II, Vol. 2422, pp. 302-315, Feb. 1995.
Jc	P. CLARK AND M. MIRMEHDI, "Location and recovery of text on oriented surfaces", In Proc. SPIE: Document Recognition and Retrieval VII, pages 267-277, 2000.
Jc	K. IKEUCHI, "Shape from regular patterns", Artificial Intelligence, 22:49-75, 1984.
Jc	K. KANATANI AND T. CHOU, "Shape from texture: general principle", Artificial Intelligence, 38:1-48, 1989.
Jc	W. POSTL, "Detection of linear oblique structures and skew scan in digitized documents", In Proc. 8 th International Conference on Pattern Recognition, pages 687-689, 1986.
Jc	E. RIBERO AND E. HANCOCK, "Improved orientation estimation from texture planes using multiple vanishing points", Pattern Recognition, 33:1599-1610, 2000.
Jc	J. SHUFELT, "Performance evaluation and analysis of vanishing point detection techniques", IEEE Trans. Pattern Analysis and machine Intelligence, 21(3):282-288, 1999.
Jc	B. SUPER AND A. BOVIK, "Planar surface orientation from texture spatial frequencies", Pattern Recognition 28(5): 729-743, 1995.

EXAMINER

DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 1 of 1

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Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 112008		APPLICATION NO. 09/901,508	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Christopher R. DANCE			
				FILING DATE July 9, 2001		GROUP 2623	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
jc	1	GB 2 305 050 A	3/26/1997	UK	←	—	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
jc	2	XP-002264506; P. Clark et al; "Location and Recovery of Text on Oriented Surfaces"; Jan 2000; SPIE Vol. 3967; pp 267-277					
jc	3	XP-002264500; T. Tuytelaars et al; "The Cascaded Hough Transform as an Aid in Aerial Image Interpretation"; pp 67-72					
jc	4	XP-002264501; Christopher R. Dance; "Perspective Estimation for Document Images"; Xerox Res. Ctr. Europe; pp 244-254					
jc	5	XP-002264502; A. Amin et al; "A Document Skew Detection Method Using the Hough Transform"; School of Computer Science & Eng.; Univ. of New South Wales; 10/20/99; pp 243-253					
jc	6	XP-000610275; Martin L. Brady et al; "Fast Parallel Discrete Approximation Algorithms for the Radon Transform"; Dept. of Elec. and Computer Eng., The Penn State University; 1992; pp 91-99					
jc	7	XP-002277760; Steve Hodges et al.; "Faster Spatial Image Processing Using Partial Summation"; Jan 1996; pp 1-40					
EXAMINER <i>Jan Chang</i>				DATE CONSIDERED <i>7/12/04</i>			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: June 8, 2004